# International **ICR** Rectifier

# POWER MOSFET THRU-HOLE (TO-254AA)

#### **Product Summary**

Part Number	RDS(on)	ID
IRFM440	0.85 Ω	8.0A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

### PD - 90492D

# IRFM440 JANTX2N7222 JANTXV2N7222 REF:MIL-PRF-19500/596 500V, N-CHANNEL HEXFET<sup>®</sup> MOSFETTECHNOLOGY



#### Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	8.0	
$I_D @ V_{GS} = 10V, T_C = 100^{\circ}C$	Continuous Drain Current	5.0	A
IDM	Pulsed Drain Current ①	32	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Max. Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy 2	700	mJ
IAR	Avalanche Current ①	8.0	Α
EAR	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt 3	3.5	V/ns
TJ	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Lead Temperature	300 ( 0.063 in.(1.6mm) from case for 10s)	
	Weight	9.3 (Typical)	g

# **Absolute Maximum Ratings**

For footnotes refer to the last page

www.irf.com

# International **ISR** Rectifier

# **Electrical Characteristics** @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	500	_	—	V	VGS = 0V, ID = 1.0mA
ΔBV <sub>DSS</sub> /ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.78	_	V/°C	Reference to 25°C, ID = 1.0mA
RDS(on)	Static Drain-to-Source On-State		—	0.85	Ω	VGS = 10V, ID = 5.0A (4)
	Resistance	—	_	0.95	32	VGS = 10V, ID = 8.0A
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
9fs	Forward Transconductance	4.7	_	—	S((7)	V <sub>DS</sub> > 15V, I <sub>DS</sub> = 5.0A ④
IDSS	Zero Gate Voltage Drain Current	-	—	25	μA	V <sub>DS</sub> = 400V ,V <sub>GS</sub> =0V
		—		250	μΑ	V <sub>DS</sub> = 400V,
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	—	100	nA	$V_{GS} = 20V$
IGSS	Gate-to-Source Leakage Reverse	_	—	-100		VGS = -20V
Qg	Total Gate Charge	_	—	68.5		VGS =10V, ID = 8.0A
Qgs	Gate-to-Source Charge	-	—	12.5	nC	V <sub>DS</sub> =250V
Q <sub>gd</sub>	Gate-to-Drain ('Miller') Charge		—	42.4	Ī	
<sup>t</sup> d(on)	Turn-On Delay Time		_	21		$V_{DD} = 250V, I_D = 8.0A,$
tr	Rise Time		—	73	ns	$V_{GS}$ =10V, $R_{G}$ = 9.1 $\Omega$
<sup>t</sup> d(off)	Turn-Off Delay Time		—	72		
tf	Fall Time		—	51		
LS+LD	Total Inductance		6.8	_	nH	Measured from drain lead (6mm/ 0.25in. from package) to source lead (6mm/0.25in. from package)
C <sub>iss</sub>	Input Capacitance	_	1300	_		$V_{GS}$ = 0V, $V_{DS}$ = 25V
C <sub>oss</sub>	Output Capacitance	—	310	—	pF	f = 1.0MHz
Crss	Reverse Transfer Capacitance	—	120			

# **Source-Drain Diode Ratings and Characteristics**

	Parameter		Min	Тур	Max	Units	Test Conditions	
IS	Continuous Source Current (Body Diode)		_	_	8.0	•		
ISM	Pulse Source Current (Body	Diode) ①		_	32	A		
VSD	Diode Forward Voltage		—	—	1.5	V	Tj = 25°C, IS = 8.0A, VGS = 0V ④	
trr	Reverse Recovery Time			_	700	nS	$T_j = 25^{\circ}C$ , $I_F = 8.0A$ , $di/dt \le 100A/\mu s$	
QRR	Reverse Recovery Charge		—	—	8.9	μC	V <sub>DD</sub> ≤ 50V ④	
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_{\text{S}}$ + $L_{\text{D}}$ .						

# **Thermal Resistance**

	Parameter	Min	Тур	Max	Units	Test Conditions
R <sub>th</sub> JC	Junction-to-Case	—	—	1.0		
RthCS	Case-to-Sink	—	0.21	—	°C/W	
RthJA	Junction-to-Ambient	—	_	48		Typical socket mount

# Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

www.irf.com

2

# International

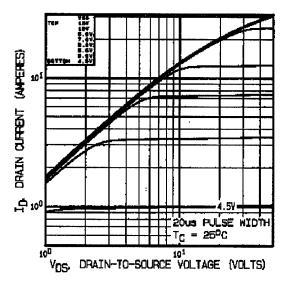


Fig 1. Typical Output Characteristics

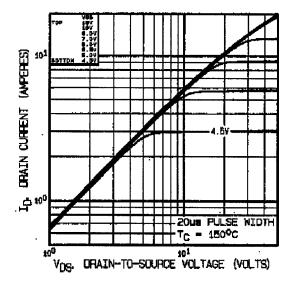


Fig 2. Typical Output Characteristics

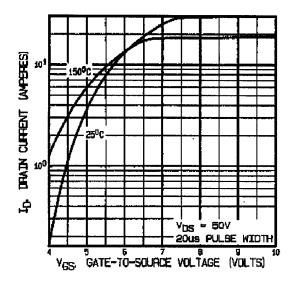


Fig 3. Typical Transfer Characteristics

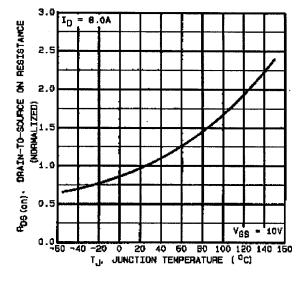


Fig 4. Normalized On-Resistance Vs. Temperature

www.irf.com

International **ICR** Rectifier

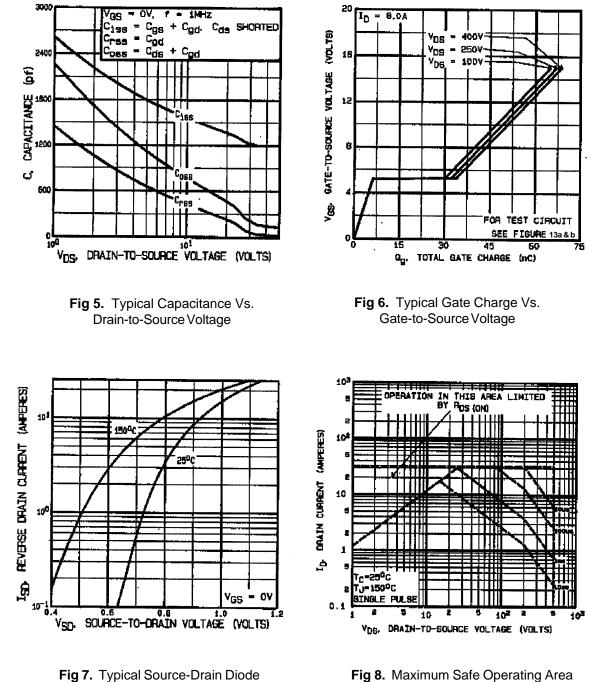


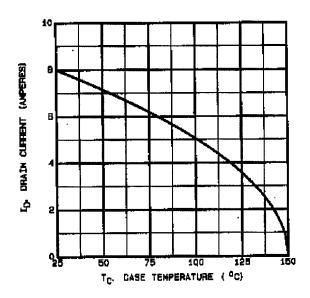
Fig 8. Maximum Safe Operating Area

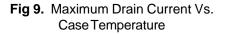
www.irf.com

4

Forward Voltage

# International





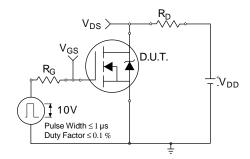


Fig 10a. Switching Time Test Circuit

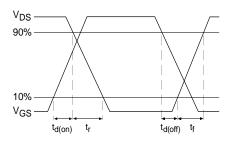


Fig 10b. Switching Time Waveforms

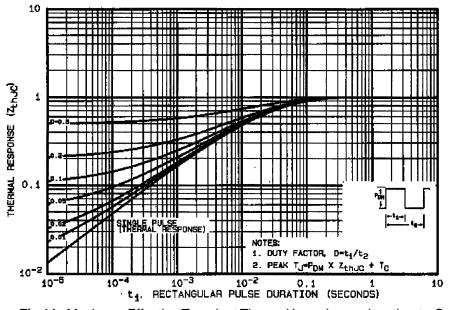


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

www.irf.com

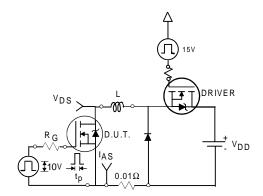


Fig 12a. Unclamped Inductive Test Circuit

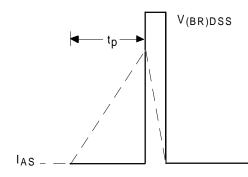


Fig 12b. Unclamped Inductive Waveforms

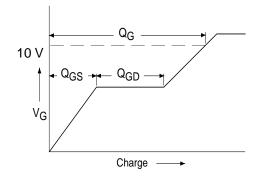


Fig 13a. Basic Gate Charge Waveform

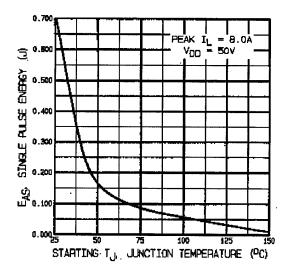


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

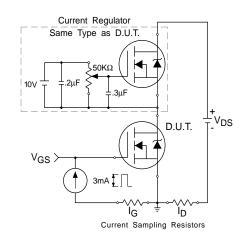


Fig 13b. Gate Charge Test Circuit

www.irf.com

6

### International **TOR** Rectifier

# Footnotes:

① Repetitive Rating; Pulse width limited by maximum junction temperature.

② VDD = 50V, starting TJ = 25°C, L= 21.8mH Peak IL = 8.0A, VGS = 10V

Case Outline and Dimensions — TO-254AA

 $3 \text{ ISD} \leq 8.0 \text{ A}, \text{ di/dt} \leq 100 \text{ A/} \mu \text{ s},$  $V_{DD} \le 500V, T_{J} \le 150^{\circ}C$ 

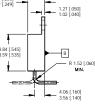
PIN ASSIGNMENTS

1 = DRAIN

2 = SOURCE3 = GATE

④ Pulse width  $\leq$  300 µs; Duty Cycle  $\leq$  2%

#### 0.12 [.005] 6.60 [.260] 13.84 [.545] 13.59 [.535] 13.84 [.545] 13.59 [.535] 6.60 [.260] 6.32 [.249] Ø 3.78 [.149] 3.53 [.139] Ø 3.78 [.149] 3.53 [.139] 1.27 [.050] A A $\oplus$ $\oplus$ 20.32 [.800] 20.07 [.790] 20.32 [.800] 20.07 [.790] 17.40 [.685 16.89 [.665 17.40 [.685] 22.73 [.895] 21.21 [.835] 13.84 [.545] 13.84 [.545] 13.59 [.535] Ċ 17.40 [.685 0.84 [.033] MAX. 4.82 [.190] 3.81 [.150] 3X Ø 1.14 [.045] 0.89 [.035] 3.81 [.150] 3X Ø 1.14 [.045] 0.89 [.035] 3.81 [.150] 3.81 [.150] ⊕ Ø 0.36 [.014] ₪ B AC



NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994

2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. 3. CONTROLLING DIMENSION: INCH.

4. CONFORMS TO JEDEC OUTLINE TO-254AA

CAUTION	

#### **BERYLLIA WARNING PER MIL-PRF-19500**

Packages containing beryllia shall not be ground, sandblasted, machined or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

# International **ICR** Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information. Data and specifications subject to change without notice. 02/02

www.irf.com